

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination MASUNO, HIROSHI	
		Examiner John R. Schnurr	Art Unit 2623	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0004415 A1	01-2002	Ito et al.	455/566
*	B	US-2003/0011704 A1	01-2003	Sawachi, Youichi	348/372
*	C	US-2003/0043260 A1	03-2003	Yap et al.	348/14.06
	D	US-			
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	J	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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